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# APPLIED PHYSICS

# Quantum interference mediated vertical molecular tunneling transistors

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Molecular transistors operating in the quantum tunneling regime represent potential electronic building blocks for future integrated circuits. However, due to their complex fabrication processes and poor stability, traditional molecular transistors can only operate stably at cryogenic temperatures. Here, through a combined experimental and theoretical investigation, we demonstrate a new design of vertical molecular tunneling transistors, with stable switching operations up to room temperature, formed from cross-plane graphene/self-assembled monolayer (SAM)/gold heterostructures. We show that vertical molecular junctions formed from pseudo-*p*-bis((4-(acetylthio)phenyl)ethynyl)-*p*-[2,2]cyclophane (PCP) SAMs exhibit destructive quantum interference (QI) effects, which are absent in 1,4-bis(((4-acetylthio)phenyl)ethynyl))benzene (OPE3) SAMs. Consequently, the zero-bias differential conductance of the former is only about 2% of the latter, resulting in an enhanced on-off current ratio for (PCP) SAMs. Field-effect control is achieved using an ionic liquid gate, whose strong vertical electric field penetrates through the graphene layer and tunes the energy levels of the SAMs. The resulting on-off current ratio achieved in PCP SAMs can reach up to ~330, about one order of magnitude higher than that of OPE3 SAMs. The demonstration of molecular junctions with combined QI effect and gate tunability represents a critical step toward functional devices in future molecular-scale electronics.

# **INTRODUCTION**

Molecular electronics represent an attractive alternative for future electronic devices with rich functionalities beyond current scaling limits (1, 2). Since molecular electronic devices can operate in the quantum tunneling regime, even at room temperature, numerous quantum phenomena at the subnanometer scale, such as nuclear spin resonance (3), quantum plasmons (4), thermoelectric effects (5), and quantum interference (QI) effects (6, 7), can be explored. Furthermore, with properly designed device structures and functional molecules (8), various functions can be implemented in molecular tunneling junctions, such as switches (9-11), diodes (12, 13), and transistors (14, 15). Normally, molecular tunneling transistors, which are the most probable electronic element in future integrated circuits, are fabricated by placing a solid back gate (16) or electrochemical gate (17) to the side of molecular junctions to tune the energy levels of the central molecules. However, due to the complex device fabrication processes and low stability of these devices, these molecular transistors can typically only operate stably at cryogenic temperatures.

Here, we report a novel design of a vertical molecular tunneling transistor with stable operation up to room temperature based on a gate/graphene/self-assembled monolayer (SAM)/gold cross-plane vertical heterostructure (*18*, *19*). The conformation and binding geometry of the molecules in the SAM are fixed (*20*) by thiol anchor groups to the gold electrode, which ensures stable charge transport across the

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molecular junctions. A strong gating electric field, generated from the electrical double layer (EDL) of ionic liquid (21), is vertically applied to the graphene/SAM/gold junctions. Because of the partial electrostatic transparency of graphene (22), the applied electric field penetrates through the graphene layer and tunes the energy levels of the SAM relative to the Dirac point of the graphene, resulting in effective gate control and a significant conductance modulation in the molecular transistors. By exploiting the molecules with destructive QI effect to suppress the molecular conductance at low bias (6), we demonstrate molecular transistors with greatly improved on-off current ratio compared to those without destructive QI effects (23).

# **RESULTS AND DISCUSSION**

## **Construction of the transistors**

The vertical molecular tunneling transistors are shown schematically in Fig. 1A (see Materials and methods and fig. S1 for detailed fabrication process). Specifically, an ultraflat Au film is deposited on the exposed conducting silicon surface in a small hole at the center of a silicon/SiO<sub>2</sub> chip, which is connected to a metal electrode at the corner and used as the source electrode. An SAM of pseudo-p-bis((4-(acetylthio)phenyl) ethynyl)-p-[2,2]cyclophane (PCP) or 1,4-bis(((4-acetylthio)phenyl) ethynyl)benzene (OPE3) molecules (Fig. 1, B and C) is then functionalized on the Au film and confirmed by atomic force microscopy (AFM), Raman characterization, and x-ray photoelectron spectroscopy (XPS) (figs. S2 and S3). A chemical vapor deposition (CVD)-grown single-layer graphene (SLG) (fig. S2D) is then transferred and patterned on the top of corresponding SAMs. A drain electrode connecting with the graphene sheet and gate electrode is laid around the functional center. Last, the graphene/ SAM/gold channel and gate electrode are covered by a small amount of diethylmethyl(2-methoxyethyl)ammonium bis(trifluoromethylsulfonyl) imide (DEME-TFSI) ionic liquid. Since the conformation and binding geometry of the molecules are fixed in SAMs (20) and the encapsulation by graphene electrodes prevents direct contact with ionic liquid, stable devices with low-noise operation can be realized.

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Fig. 1. Schematic illustration of the vertical molecular tunneling transistor. (A) Schematic illustration of the overall device structure. (B) Chemical structure of the PCP and OPE3 molecules. (C) Schematic illustration of the molecular transistor with OPE3 SAMs and ionic liquid (DEME-TFSI) gating. DEME<sup>+</sup> ions are the cations, and TFSI<sup>-</sup> ions comprise the anions.

# Charge transport in molecular junctions

In contrast to the fully conjugated molecular chain in OPE3, a fundamental difference of PCP molecules is the presence of spatially separated aromatic rings linked by saturated methylene bridges in PCP. In this case, a current path mediated by  $\pi$ - $\pi$  overlap between aromatic rings acts in parallel with current paths through the methylene bridges to create destructive QI features between the highest occupied molecular orbital (HOMO) and the HOMO-1, as shown in fig. S4 (A and B) and in the literature (23). When combined with interruption of the conjugation in the PCP molecule, this results in a lower transmission coefficient T(E) for the PCP molecule compared with OPE3. As shown in Fig. 2B, the computed ratio of their transmission coefficients in graphene-molecule gold junctions for PCP and OPE at  $E = E_{\rm F}^{\rm Gold}$ (where  $E_{\rm F}^{\rm Gold}$  is the Fermi energy of the gold electrode) is  $\frac{T_{\rm OPE}(E_{\rm F}^{\rm Gal})}{T_{\rm PCP}(E_{\rm F}^{\rm Gal})} \approx 135$ .

To fully understand the origin of this difference, a comparison between the molecular orbitals of PCP and OPE3 is presented in fig. S4C (*24*), along with a discussion of their mutual QI features.

The experimental current density ( $J_D$ ) versus bias voltage  $V_D$  and the differential conductance (dJ/dV) versus  $V_D$  are shown in Fig. 2 (C and D). The current density ( $J_D$ ) for the PCP junction is considerably lower than that of the OPE3 junction, especially near zero bias, which is consistent with the transmission coefficient characteristics of the respective molecules discussed above. The minima in the dJ/dV curves are associated with the Dirac point of the graphene, and their positions relative to the zero  $V_D$  indicate whether the graphene is p-doped or n-doped. In Fig. 2D, the Dirac point for OPE3 and PCP samples occurs at -0.3 and 0 V, respectively, indicating that the graphene is n-doped in the OPE3 sample and negligibly doped in PCP sample. For this reason, in what follows, when comparing our calculated T(E) with experiments, the band structure of the graphene is adjusted to place the Dirac point of the OPE3 system at -0.3 eV and of the PCP system at 0 eV.

Figure 3 (D and G) shows the  $V_{\rm D}$  dependence of T(E) versus  $E - E_{\rm F}^{\rm Gold}$  for PCP and OPE3. It is assumed that the energies of the molecular levels relative to  $E_{\rm F}^{\rm Gold}$  are independent of  $V_{\rm D}$  and that positive (negative) bias voltage decreases (increases) the Dirac point relative to

 $E_F^{\text{Gold}}$  (Eq. 1 in the "Theoretical methods" section). The current is computed using Eq. 4 (see the "Theoretical methods" section) by evaluating individual transmission coefficients  $T(E, V_D, V_G)$  at every  $V_D$  value and computing the associated current. The dI/dV curves are then obtained by differentiating the current with respect to  $V_D$ .

From the experimental results of Fig. 2D, the value of dJ/dV at zero bias for OPE3 is 71 times larger than that for PCP. From statistics of 12 different experimental PCP and OPE3 junctions, the zero-bias differential conductance for OPE3 is 56 times larger than that for PCP (section S4). This ratio is comparable with the value of 65 obtained from the calculated results of Fig. 2F. For PCP and OPE3 junctions with gold-molecule-gold contacts (fig. S4, A and B), the conductance ratio at zero bias is  $G_{OPE3}/G_{PCP} = 5$ , which is only about one-tenth of junctions with gold-molecule-graphene contacts. This indicates that the conductance for molecule junctions with graphene electrode is more sensitive to the structure of molecules and their relative energy alignment.

# Field effect properties of the transistors

To probe the field effect transistor functions of the molecular junctions, DEME-TFSI ionic liquid was used for gating, which has a high ionic conductivity, a large electrochemical window, and a low glass transition temperature of 182 K for ion migration (25). When a gate voltage ( $V_{\rm G}$ ) is applied to the gate electrode, a Helmholtz EDL is expected to selforganize on the surface of graphene/SAM/gold junction (Fig. 3A) with generation of a strong electric field of up to ~10 MV/cm (21). The gate performances for PCP and OPE3 transistors were measured at both room temperature (298 K) and 200 K and show similar characteristics between the two temperatures (Fig. 4 and fig. S7, A to L). Figure 4 (A and D) shows typical gate-dependent  $J_{\rm D}$ - $V_{\rm D}$  characteristics measured at 200 K for PCP and OPE3. With  $V_{\rm G}$  changing from -1 to 1 V,  $J_{\rm D}$  greatly increases with  $V_{\rm G}$ for negative  $V_D$ , while  $J_D$  greatly decreases with  $V_G$  for positive  $V_D$ . On the other hand, the gate-dependent J<sub>D</sub> amplitude for OPE3 is evidently much smaller than that for PCP. This demonstrates the better gate control over the vertical PCP molecular transistors compared with OPE3.

The conductance minima for both molecules move in a positive (negative) direction along the  $V_{\rm D}$  axis when the  $V_{\rm G}$  is increased

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**Fig. 2.** Charge transport in molecular junctions. (A) Schematic illustration of the PCP and OPE3 junctions. (B) Transmission functions T(E) for PCP (red) and OPE3 (black). Insets show the junction structures for simulation. (C) Plots of experimental current density ( $J_D$ ) versus bias voltage ( $V_D$ ) for PCP and OPE3. (D) Experimental differential conductance (dJ/dV) versus  $V_D$  plots for PCP and OPE3. (E) Theoretical current ( $I_D$ ) versus  $V_D$  plots for PCP and OPE3. (F) Theoretical differential conductance (dJ/dV) versus  $V_D$  plots for PCP and OPE3. (E) Theoretical current ( $I_D$ ) versus  $V_D$  plots for PCP and OPE3. (F) Theoretical differential conductance (dJ/dV) versus  $V_D$  plots for PCP and OPE3.

(decreased) (Fig. 4, B and E). This feature is independent of the type of molecule and is a reflection of the  $V_{\rm G}$  dependence of the Dirac point of graphene (Fig. 3B). Figure 4C shows a two-dimensional visualization of dJ/dV plotted versus  $V_{\rm G}$  and  $V_{\rm D}$  for PCP. The oblique diamondshaped low-conductance region (green) indicates off-resonant transport, while the red-orange high-conductance region outside the diamond is due to the conductive frontier molecular orbitals entering the bias window. Furthermore, a blue minimum conductance region appears at the center of the diamond, which corresponds to the Dirac point of the graphene. For the OPE3 transistor (Fig. 4F), a similar oblique diamond-shaped low-conductance region can be observed as well. However, the relative conductance changing between center low and outside high-conductance regions for OPE3 is considerably smaller than that for PCP, which reflects the better gating tunability for PCP. This is in agreement with the calculated T(E) for PCP and OPE3 (Fig. 2B), as the difference between off-resonant and resonant

transport is more pronounced for PCP in comparison with OPE3. Furthermore, the  $V_{\rm G}/V_{\rm D}$  slope for the edges of diamonds at the second and fourth quadrants is 0.2095 for OPE3, which is smaller than that for PCP with a value of 0.2493. This further demonstrates that the gate controllability for PCP is better than that for OPE3.

#### Working mechanism of the transistors

Figure 3C illustrates how the  $V_{\rm G}$  induced by the ionic liquid affects the band structure of the graphene and the molecular energy levels. Note that the Fermi energy  $(E_{\rm F}^{\rm Gold})$  of the gold is independent of  $V_{\rm G}$ or  $V_{\rm D}$ , since it is earthed in this study. In our theoretical model, the  $V_{\rm G}$ can move the energy levels of the graphene, as well as molecular energy levels (Eqs. 1, 2, and 3 in the "Theoretical methods" section). Therefore, the position of the highest occupied molecular orbital (HOMO) and lowest unoccupied molecular orbital (LUMO) relative to the Fermi energy of the gold varies with  $V_{\rm G}$ .

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**Fig. 3. Charge transport in vertical molecular transistors. (A)** Schematic illustration of the working device with EDLs. **(B)** Schematic band diagram of the device with changed  $V_D$  at graphene electrode. **(C)** Schematic band diagram of the device with changed  $V_G$ . **(D** and **G)** Transmission coefficient *T*(E) versus  $E - E_F^{\text{Gold}}$  for PCP (D) and OPE3 (G) junctions for  $-0.4 < V_D < 0.4$  with steps of 0.2 V. **(E** and **H)** Gate-dependent theoretical  $I_D$ - $V_D$  characteristics for PCP (E) and OPE3 (H). **(F** and **I)** Gate-dependent theoretical  $d/dV-V_D$  for PCP (F) and OPE3 (I).  $V_G$  is varied from -0.6, -0.3, 0.0, 0.3, to 0.6 V in (E), (F), (H), and (I).



**Fig. 4. Gating charge transport in experimental molecular transistors.** (**A** and **B**)  $J_D$  versus  $V_D$  characteristics (A) and d//dV versus  $V_D$  characteristics (B) for PCP with  $V_G$  varying from –1 to 1 V with step of 0.5 V. (**C**) Two-dimensional visualization of d//dV plotted versus  $V_G$  and  $V_D$  for PCP. (**D** and **E**)  $J_D$ - $V_D$  characteristics (D) and d//dV- $V_D$  characteristics (E) for OPE3 with gating from –1 to 1 V with step of 0.5 V. (**F**) Two-dimensional visualization of d//dV plotted versus  $V_G$  and  $V_D$  for OPE3. Insets in (A) and (D) show schematics of the PCP and OPE3 transistors with applied vertical electric field. Black lines in (C) and (F) are auxiliary markers of corresponding conductance diamond edge.

Similar to the bias voltage lever arm ( $\alpha$ ), we consider a  $V_{\rm G}$  lever arm ( $\beta$  in Eq. 1; see the "Theoretical methods" section). In the experimental dJ/dV of the OPE3 sample, we can see that the Dirac point of graphene moves up by 0.4 V when the  $V_{\rm G}$  is increased by 1 V (Fig. 4E). For a similar change in  $V_{\rm G}$ , the Dirac point moves up by 0.5 V in the PCP sample (Fig. 4B). Therefore, to compare our calculations with experiment, we choose  $\beta = 0.4$ . This assumption allows us to model the sensitivity of these devices to the change in  $V_{\rm G}$  and  $V_{\rm D}$  and yields agreement with our experiments. For example, a 1.2-V change in the  $V_{\rm G}$  of the PCP device moves the Dirac point of the graphene by 0.48 V along the  $V_{\rm D}$  axis (red curve and blue curve in Fig. 3F). Similar behavior also occurs in OPE3 junctions (Fig. 3I), namely, the orbital energies only vary with  $V_{\rm G}$ , whereas the Dirac point and transmission minima are sensitive to both  $V_{\rm D}$  and  $V_{\rm G}$  (Fig. 3C).

The  $V_{\rm D}$ - and  $V_{\rm G}$ -dependent transmission coefficient  $T(E, V_{\rm D}, V_{\rm G})$ was calculated using a quantum transport code, the GOLLUM (26), and the current obtained from Eq. 4 (see the "Theoretical methods"). The theoretical gate-dependent  $I_{\rm D}$ - $V_{\rm D}$  characteristics for PCP (Fig. 3E) reveal that, when  $V_{\rm G}$  changes from -0.6 to 0.6 V,  $I_{\rm D}$  greatly increases with  $V_{\rm G}$  for negative  $V_{\rm D}$ , while  $I_{\rm D}$  decreases with  $V_{\rm G}$  for positive  $V_{\rm D}$ . A similar theoretical gate-dependent  $I_{\rm D}$ - $V_{\rm D}$  characteristic is also obtained for OPE3 (Fig. 3H), although the gate-dependent change in  $I_{\rm D}$  is smaller than that for PCP. Furthermore, from the gate-dependent dI/dV- $V_{\rm D}$  characteristics for PCP (Fig. 3F), it can be observed that the dI/dV- $V_{\rm D}$  curve shifts in a positive direction with  $V_{\rm G}$  changing from -0.6to 0.6 V, especially for the lowest conductance points. For OPE3, a similar gate-dependent dI/dV- $V_{\rm D}$  curve is obtained, but with a relatively smaller amplitude (Fig. 3I), in qualitative agreement with the experimental results (Fig. 4).

# Transfer characteristics of the transistors

Transfer characteristics, which monitor the current modulation by varying  $V_{\rm G}$  at a fixed  $V_{\rm D}$ , are widely used for evaluating the performance of transistors (27). Experimental transfer characteristics  $(J_D - V_G)$  for PCP at  $V_{\rm D}$  = -0.1, -0.2, -0.4, -0.6, and -0.8 V are shown in Fig. 5A. It can be observed that the lowest current point at  $V_{\rm D} = -0.1$  V is near  $V_{\rm G} = 0$  V, and as  $V_{\rm D}$  increases from -0.1 to -0.8 V, the lowest current point shifts to a more negative  $V_{\rm D}$ . This shifting of the lowest current point is due to variation on the Dirac point of the graphene electrode. With a more negative  $V_{\rm D}$ , an increased negative  $V_{\rm G}$  is needed to move the central transmission dip of the junction to the middle of the bias window. Similar behavior occurs for  $J_{\rm D}$ - $V_{\rm G}$  curves with positive  $V_{\rm D}$ (fig. S8E). Furthermore, the on-off ratio, which corresponds to the ratio between the highest and lowest currents in a  $J_D$ - $V_G$  curve, decreases with increasing  $V_{\rm D}$ . The highest on-off ratio of ~320 is achieved for PCP near  $V_{\rm D} = 0$  V. The on-off ratio decreases with increasing  $V_{\rm D}$ , which can be attributed to electron transmission occurring over a wider bias window, with the conductance less sensitive to gating-induced movement of molecular energy levels. Similar transfer characteristics (Fig. 5B) and a  $V_{\rm D}$ -dependent on-off ratio (fig. S8g) also appear for OPE3, although with a peak on-off ratio value of ~34, which is only 10% of the PCP value. These behaviors cannot be observed for the graphene device without SAMs (fig. S9, A to F), which is indicative of the unique field-effect behavior for the vertical molecular transistors. The  $V_{\rm D}$ -dependent transfer characteristics for PCP and OPE3 were also investigated by theoretical simulations. From the theoretical transfer characteristics  $(I_D - V_G)$  for PCP (Fig. 5C) and OPE3 (Fig. 5D), as  $V_D$  changes from -0.1 to -0.8 V, it can be observed that, with increased negative  $V_{\rm D}$ , on-off ratios decrease and the lowest current points shift to the negative



Fig. 5. Transfer characteristics for the vertical molecular transistors. (A) Experimental transfer characteristics for PCP. (B) Experimental transfer characteristics for OPE3. (C) Theoretical transfer characteristics for PCP. (D) Theoretical transfer characteristics for OPE3.  $V_D$  is varied from -0.1, -0.2, -0.4, -0.6, to -0.8 V in (A) to (D).

direction. In agreement with our measurements, the peak value of onoff ratio for PCP is about one order of magnitude higher than that of the OPE3 (fig. S8H).

# CONCLUSION

In summary, we have demonstrated molecular transistors using vertical cross-plane graphene/SAM/gold heterostructures and ionic liquid gating. We show that charge transport across the vertical junction and transistor characteristics can be readily tailored by selecting molecules with or without destructive QI features (e.g., PCP- versus OPE3based junctions). We show that a graphene/PCP-SAM/gold junction can show a significant current modulation by an ionic liquid gate, with a maximum on-off ratio of up to 330, which is about one order of magnitude higher than that for OPE3. This better gate behavior for PCP is a direct consequence of the zero-bias conductance suppression induced by destructive QI. The designed vertical molecular transistors with large on-off ratios could form the basic electronic building blocks for future electronics and may offer a robust platform for exploring gate-dependent quantum transport phenomena (3, 14, 15), especially when the ionic liquid gate is further replaced by a solid high-k gate (27). Furthermore, these QI-driven vertical molecular transistors, with sensitive gating applied outside of the top graphene electrode, can be further used for fabricating various functional devices, such as chemical and biological sensors (28, 29).

## MATERIALS AND METHODS

# **Device fabrication**

A silicon wafer [single-side polished, N-type with arsenic dopant, (111) orientation, 0.001- to 0.004-ohm · cm resistivity, and 380-µm thickness coated by 300-nm thermally grown SiO<sub>2</sub>] was cut into proper size and further cleaned for use. After a photolithographic process (a Karl Suss MA6 Contact Aligner, AZ 5214-E IR Photoresist, AZ Developer), a resist mask with a 80-µm hole was covered with silicon wafer. Next, a 300-nm SiO<sub>2</sub> layer in the patterned hole was selectively removed by buffered oxide etchant (BOE, 1:6 HF:NH4F) for 5 min, which let the silicon surface exposed out. Then, the silicon wafer was annealed in air in a split tube furnace (Thermo Fisher Scientific Lindberg/Blue M) with a 1-inch quartz tube for 45 min at 960°C. During this annealing process, a 30-nm-thick layer of SiO<sub>2</sub> was thermally grown on the exposed silicon surface in the hole, which was confirmed by a film thickness measurement (SCI FilmTek 2000). After a second photolithographic process and an e-beam and thermal evaporation (CHA Mark 40 Evaporator), metal marks and gate electrode with Ti/Au (20/60 nm) were laid around the pretreated hole. With a poly(methyl methacrylate) (PMMA) layer [495, A8; 4000 revolutions per minute (rpm), 40 s; baked for 5 min at 150°C] spin coated on the sample, three square holes approaching 1.5 µm by 1.5 µm were fabricated by an e-beam lithography processes in the center of the 80-µm hole. Through the PMMA mask, a 30-nm SiO<sub>2</sub> layer in the patterned small holes was removed by BOE for 5 min, which let the conductive silicon surface exposed out. Immediately after the BOE etching, an ultraflat Ti/Au (5/23 nm) thin film was e-beam evaporated on the exposed silicon surface through the same mask with patterned small holes. After lifting off in acetone, the samples were stored in a vacuum desiccator for further use.

PCP and OPE3 were used as same with that in our previous work (23). Before molecule assembling, the samples with gold films were annealed at 250°C for 3 hours in a glove box [Glove Box Mikrouna,

<1 parts per million (ppm) of O<sub>2</sub>/H<sub>2</sub>O]. For PCP and OPE3 assembling on the gold film on silicon wafers, 50 µM solutions of the SAc-protected wire in distilled toluene were prepared in the glove box (<1 ppm of O<sub>2</sub>/ H<sub>2</sub>O). Then, the pretreated samples were immersed into 5 ml of corresponding solutions for at least 12 hours in the glove box. Two hours before taking the samples out for further fabrication, 0.09 ml of 0.05:20 DBU (1,8-diazabicyclo[5.4.0]undec-7-ene):distilled toluene solution was added into the reaction solution, and the reaction flask was shaken a little to help the mixing. After 2 hours, the samples were taken out from the vials and in turn washed with distilled toluene and ethanol three times by immersing the samples in fresh solvent. Last, the samples were blow dried with a N<sub>2</sub> gas stream.

A high-quality SLG was grown on 25-µm-thick copper films (Alfa Aesar), pretreated with glacial acetic acid, by using a low-pressure CVD method with optimal conditions (30). Then, a PMMA layer (495, A8; 2000 rpm, 30 s; baked for 2 min at 180°C) was spin coated on SLG/Cu. By using a wet etching technique, we etched the Cu layer with formation of a PMMA/SLG film. With aid of isopropanol, the PMMA/SLG film was transferred on samples with corresponding molecular SAMs. Next, with a photolithographic process and selective oxygen plasma etching (Tegal Plasmaline 515 System), graphene sheets were patterned to cover the 80-µm hole with SAMs at the center. After another photolithographic process, Ti/Au (20/60 nm) was thermally evaporated to make drain electrodes with connection to graphene sheets and source electrodes at the corner with connection to the back of the conductive silicon layer. Notably, before photoresist lift-off, a 30-nm Al<sub>2</sub>O<sub>3</sub> layer was deposited by e-beam evaporation, and another 20-nm Al<sub>2</sub>O<sub>3</sub> layer was deposited by atomic layer deposition (Cambridge Nanotech Inc., Savannah 100 and 200), which can passivate the surface of metal electrodes for reducing leakage current during ionic liquid gating. With another e-beam lithographic process and BOE etching, the covered Al<sub>2</sub>O<sub>3</sub> layer on the source electrode at the corner was removed.

The compared graphene devices were fabricated by the same processes with the graphene layer directly deposited on top of the Ti/Au layer without SAMs. For the control 1-octadecanethiol (C18) devices, C18 SAMs were assembled by immersing the pretreated samples into 5 ml of 100  $\mu$ M solutions of 1-octadecanethiol in anhydrous ethanol for 12 hours. Other fabrication processes were unchanged.

The fabricated devices were stored in a vacuum desiccator for further measurement. Before electrical measurements, a small drop of DEME-TFSI ionic liquid, where DEME<sup>+</sup> ions are the cations and TFSI<sup>-</sup> ions comprise the anions, was dropped on the device, covering the graphene-SAMs channel and the core part of gate electrode. Charge transport properties and ionic liquid gating performances of the devices were measured at room temperature (298 K) and 200 K by precision source/measure unit system (Keysight Agilent B2902A) and a Model TTPX cryogenic probe station (Lake Shore Cryotronics Inc.) with liquid nitrogen. The differential conductance data dJ/dV were obtained by numerical differentiation of the corresponding *J* versus *V* data.

# **Device characterization**

Bruker Dimension FastScan Scanning Probe Microscope (SPM) was used for AFM measurements of the prepared samples with a tapping mode. The measured AFM images were further analyzed by a Nanoscope analysis software. Kratos Axis Ultra XPS system (AlK $\alpha$  radiation; power,  $\leq$ 180 W) was used for obtaining high-resolution XPS (HR-XPS) data of the samples.

Raman measurements were carried out on a LabRAM HR Evolution Raman spectrometer (Horiba Scientific) with an excitation wavelength of 632.8 nm. A gold film with a thickness of 8 nm was used for surfaceenhanced Raman spectroscopy of SAM samples (*31*).

# **Computational details**

The ground-state Hamiltonian and optimized geometry of each molecule was obtained using the density functional theory code SIESTA (Spanish Initiative for Electronic Simulations with Thousands of Atoms) (32). The local density approximation exchange correlation functional was used along with double zeta-polarized (DZP) basis sets and norm-conserving pseudo-potentials. The real space grid is defined by a plane-wave cutoff of 185 rydberg. The geometry optimization was carried out to a force tolerance of 0.01 eV/Å. This process was repeated for a unit cell with the molecule between gold and graphene electrodes, where the optimized distance between graphene and the thiol anchor group was found to be 2.9 Å.

## **Theoretical methods**

To model the periodicity in the graphene and interaction between the molecules in the SAM, the unit cell was repeated using a Bravias lattice with 30 *k*-points in the *y* direction. This models an SAM where molecules are  $\sim$ 2 nm apart. The gold electrode is considered to be a nanowire and not periodic. A mean-field Hamiltonian and an overlap matrix were extracted from this converged calculation.

To model the source-drain and  $V_{\rm G}$  in the experiment, we used a model where the gold lead is earthed, and therefore, the gold Fermi energy ( $E_{\rm F}^{\rm Gold}$ ) is not affected by the source-drain or gate voltage. However, the Fermi energy of graphene is a function of the source-drain and gate voltages via the equation

$$E_{\rm F}^{\rm Gr}(V_{\rm D}, V_{\rm G}) = E_{\rm F}^{\rm Gold} - \alpha V_{\rm D} - \beta V_{\rm G} \tag{1}$$

where  $V_{\rm D}$  and  $V_{\rm G}$  are the source-drain and gate voltages, and  $\alpha$  and  $\beta$  are the experimental lever arms, which could vary in each experiment. Similarly, applying a  $V_{\rm G}$  can move the energy levels of the molecule up and down in energy (Eqs. 2 and 3)

$$\epsilon^{HOMO}(V_G) = \epsilon_m^{HOMO} - \gamma_G V_G \tag{2}$$

$$\boldsymbol{\varepsilon}^{\text{LUMO}}(\mathbf{V}_G) = \boldsymbol{\varepsilon}_{\mathrm{m}}^{\text{LUMO}} - \boldsymbol{\gamma}_{\mathrm{G}} \boldsymbol{V}_{\mathrm{G}} \tag{3}$$

The value for current is given by Eq. 4

$$I(V_D, V_G) = \frac{2e}{h} \int_{E_{\rm F}^{\rm Gold}}^{E_{\rm F}^{\rm Gol}(V_D, V_G)} T(E, V_D, V_G) dE$$
(4)

where  $T(E, V_D, V_G)$ , is the transmission coefficient from lead 1 to lead 3 calculated using quantum transport code the GOLLUM (26). In what follows,  $\gamma_G = 1$ . When comparing theory with experiment, e.g., in Fig. 2, a lever arm of  $\alpha = 0.44$  was used.

#### SUPPLEMENTARY MATERIALS

Supplementary material for this article is available at http://advances.sciencemag.org/cgi/ content/full/4/10/eaat8237/DC1

Section S1. Supplementary for device fabrication

Section S2. Characterization of the devices

Section S3. Supplementary for theoretical calculations

Section S4. Supplementary charge transport in PCP and OPE3 devices

- Section S5. The performances for compared devices
- Fig. S1. Fabrication procedure for the vertical molecular transistor.
- Fig. S2. AFM and Raman characterizations.
- Fig. S3. HR-XPS characterizations.
- Fig. S4. Supplementary theoretical calculations. Fig. S5. Charge transport in PCP devices.
- Fig. S6. Charge transport in OPE3 devices.
- Fig. S7. Temperature-dependent performances for PCP and OPE3.
- Fig. S8. Supplementary gate performances for PCP and OPE3 transistors.
- Fig. S9. Gate performances for compared graphene and C18 devices.

Table S1. Statistic conductance for PCP and OPE3 junctions.

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